Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/613,488	CERVINKA ET AL.
Examiner	Art Unit

2618

TUAN A. PHAM

SEARCHED				
Class	Subclass	Date	Examiner	
455	63.1	4/6/2006	РНАМ	
	63.2			
	67.11	_		
	67.13			
	501			
	509	4/7/2006	PHAM	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH	STRATEGY	)
	DATE	EXMR
Consulted with:		
Nguyen Vo	4/7/2006	РНАМ
Duc Nguyen		
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